Notice of References Cited	10/606,375	Reexamination KAMOTO ET AL.	
	Examiner	Art Unit	_

Application/Control No.

Page 1 of 1 Tu M. Nguyen 3748

Applicant(s)/Patent Under

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	А	US-6,539,707	04-2003	Ikemoto et al.	60/285
*	В	US-6,622,478	09-2003	Nakamura, Takeshi	60/285
*	С	US-6,751,950	06-2004	Ikemoto et al.	60/285
	D	US-			
	E	US-			3
	F	US-			
	G	US-		·	·
	Н	US-			
	ı	US-			
	J	US-			
	К	US-			3
	L	US-		·	
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν					
	0		. "			3
	Р					
	Ø					
	R					
	Ø					,
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	3
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.